

Moissanite-6H SiC (*B*6) Structure:

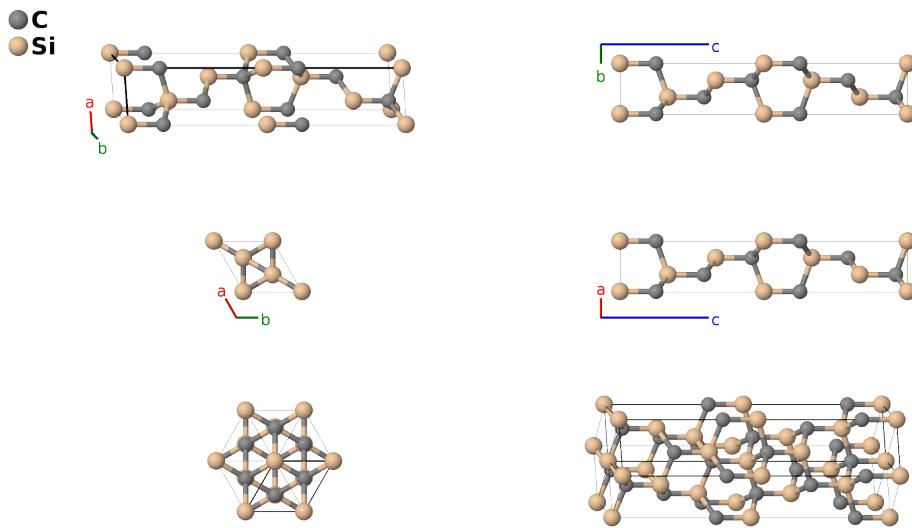
AB_hP12_186_a2b_a2b-001

This structure originally had the label AB_hP12_186_a2b_a2b. Calls to that address will be redirected here.

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<https://aflow.org/p/NYRK>

https://aflow.org/p/AB_hP12_186_a2b_a2b-001



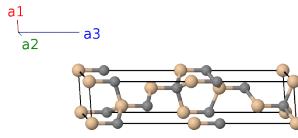
Prototype	SiC
AFLOW prototype label	AB_hP12_186_a2b_a2b-001
Strukturbericht designation	<i>B</i> 6
Mineral name	moissanite
ICSD	156190
Pearson symbol	hP12
Space group number	186
Space group symbol	<i>P</i> 6 ₃ <i>mc</i>
AFLOW prototype command	<code>aflow --proto=AB_hP12_186_a2b_a2b-001 --params=a, c/a, z₁, z₂, z₃, z₄, z₅, z₆</code>

- This is an alternate stacking (ABCACB) for tetrahedral structures. Compare this to zincblende (*B*3, ABCABC), moissanite-4H (*B*5, ABAC), and wurtzite (*B*4, ABABAB).
- The 6H refers to the fact that there are 6 CSi dimers in a hexagonal unit cell. Zincblende is denoted 3C, and wurtzite is 2H.
- Without loss of generality, we can take any of the z_i to be zero. Here we take $z_2 = 0$ for the silicon (2a) site.

- The ICSD entry is from the later work of (Capitani, 2007).

Hexagonal primitive vectors

$$\begin{aligned}\mathbf{a}_1 &= \frac{1}{2}a\hat{\mathbf{x}} - \frac{\sqrt{3}}{2}a\hat{\mathbf{y}} \\ \mathbf{a}_2 &= \frac{1}{2}a\hat{\mathbf{x}} + \frac{\sqrt{3}}{2}a\hat{\mathbf{y}} \\ \mathbf{a}_3 &= c\hat{\mathbf{z}}\end{aligned}$$



Basis vectors

	Lattice coordinates	Cartesian coordinates	Wyckoff position	Atom type
\mathbf{B}_1	$z_1 \mathbf{a}_3$	$c z_1 \hat{\mathbf{z}}$	(2a)	C I
\mathbf{B}_2	$(z_1 + \frac{1}{2}) \mathbf{a}_3$	$c(z_1 + \frac{1}{2}) \hat{\mathbf{z}}$	(2a)	C I
\mathbf{B}_3	$z_2 \mathbf{a}_3$	$c z_2 \hat{\mathbf{z}}$	(2a)	Si I
\mathbf{B}_4	$(z_2 + \frac{1}{2}) \mathbf{a}_3$	$c(z_2 + \frac{1}{2}) \hat{\mathbf{z}}$	(2a)	Si I
\mathbf{B}_5	$\frac{1}{3} \mathbf{a}_1 + \frac{2}{3} \mathbf{a}_2 + z_3 \mathbf{a}_3$	$\frac{1}{2}a\hat{\mathbf{x}} + \frac{\sqrt{3}}{6}a\hat{\mathbf{y}} + cz_3\hat{\mathbf{z}}$	(2b)	C II
\mathbf{B}_6	$\frac{2}{3} \mathbf{a}_1 + \frac{1}{3} \mathbf{a}_2 + (z_3 + \frac{1}{2}) \mathbf{a}_3$	$\frac{1}{2}a\hat{\mathbf{x}} - \frac{\sqrt{3}}{6}a\hat{\mathbf{y}} + c(z_3 + \frac{1}{2})\hat{\mathbf{z}}$	(2b)	C II
\mathbf{B}_7	$\frac{1}{3} \mathbf{a}_1 + \frac{2}{3} \mathbf{a}_2 + z_4 \mathbf{a}_3$	$\frac{1}{2}a\hat{\mathbf{x}} + \frac{\sqrt{3}}{6}a\hat{\mathbf{y}} + cz_4\hat{\mathbf{z}}$	(2b)	C III
\mathbf{B}_8	$\frac{2}{3} \mathbf{a}_1 + \frac{1}{3} \mathbf{a}_2 + (z_4 + \frac{1}{2}) \mathbf{a}_3$	$\frac{1}{2}a\hat{\mathbf{x}} - \frac{\sqrt{3}}{6}a\hat{\mathbf{y}} + c(z_4 + \frac{1}{2})\hat{\mathbf{z}}$	(2b)	C III
\mathbf{B}_9	$\frac{1}{3} \mathbf{a}_1 + \frac{2}{3} \mathbf{a}_2 + z_5 \mathbf{a}_3$	$\frac{1}{2}a\hat{\mathbf{x}} + \frac{\sqrt{3}}{6}a\hat{\mathbf{y}} + cz_5\hat{\mathbf{z}}$	(2b)	Si II
\mathbf{B}_{10}	$\frac{2}{3} \mathbf{a}_1 + \frac{1}{3} \mathbf{a}_2 + (z_5 + \frac{1}{2}) \mathbf{a}_3$	$\frac{1}{2}a\hat{\mathbf{x}} - \frac{\sqrt{3}}{6}a\hat{\mathbf{y}} + c(z_5 + \frac{1}{2})\hat{\mathbf{z}}$	(2b)	Si II
\mathbf{B}_{11}	$\frac{1}{3} \mathbf{a}_1 + \frac{2}{3} \mathbf{a}_2 + z_6 \mathbf{a}_3$	$\frac{1}{2}a\hat{\mathbf{x}} + \frac{\sqrt{3}}{6}a\hat{\mathbf{y}} + cz_6\hat{\mathbf{z}}$	(2b)	Si III
\mathbf{B}_{12}	$\frac{2}{3} \mathbf{a}_1 + \frac{1}{3} \mathbf{a}_2 + (z_6 + \frac{1}{2}) \mathbf{a}_3$	$\frac{1}{2}a\hat{\mathbf{x}} - \frac{\sqrt{3}}{6}a\hat{\mathbf{y}} + c(z_6 + \frac{1}{2})\hat{\mathbf{z}}$	(2b)	Si III

References

- [1] A. Bauer, P. Reischauer, J. Kräusslich, N. Schell, W. Matz, and K. Goetz, *Structure refinement of the silicon carbide polytypes 4H and 6H: unambiguous determination of the refinement parameters*, Acta Crystallogr. Sect. A **57**, 60–67 (2001), doi:10.1107/S0108767300012915.
- [2] N. W. Thibault, *Morphological and Structural Crystallography and Optical Properties of Silicon Carbide (SiC) Part II: Structural Crystallography and Optical Properties*, Am. Mineral. **29**, 327–362 (1944).
- [3] G. C. Capitani, S. D. Pierro, and G. Tempesta, *The 6H-SiC structure model: Further refinement from SCXRD data from a terrestrial moissanite*, Am. Mineral. **92**, 403–407 (2007).